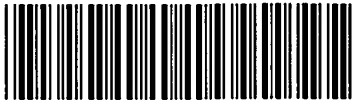


Search Notes

Application/Control No.

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Examiner

Helen C. Kwok

Applicant(s)/Patent under
Reexamination

DEB ET AL.

Art Unit

2856

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
73	514.32	11/23/2005	HK
73	504.14	11/23/2005	HK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated Previous Search	11/23/2005	HK